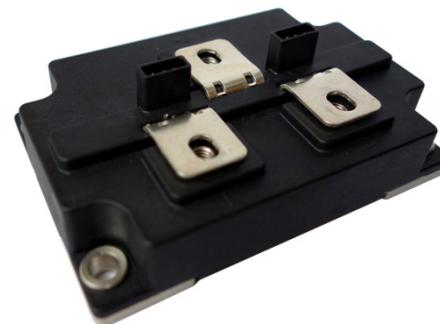


## PRODUCT FEATURES

- $R_{DS(ON),typ}=1.8m\Omega @ V_{GS}=10V$
- 175°C junction temperature
- Low Gate Charge Minimize Switching Loss
- Fast Recovery body Diode
- 20K  $\Omega$  Gate Protected Resistance Inside



## APPLICATIONS

- High efficiency DC/DC Converters
- ISG EV Products
- UPS inverter

Type	$V_{DS}$	$I_D$	$R_{DS(ON),max} \quad T_J=25^\circ C$	$T_{Jmax}$	Marking	Package
MMN600DB015B	150V	600A	2.1m $\Omega$	175°C	MMN600DB015B	NDB

## ABSOLUTE MAXIMUM RATINGS

 *$T_C=25^\circ C$  unless otherwise specified*

Symbol	Parameter/Test Conditions		Values	Unit
$V_{DSS}$	Drain Source Voltage	$T_J=25^\circ C$	150	V
$V_{GSS}$	Gate Source Voltage		$\pm 20$	
$I_D$	Continuous Drain Current	$T_C=25^\circ C$	850	A
		$T_C=100^\circ C$	600	
$I_{DM}$	Pulsed Drain Current at $V_{GS}=10V$	Limited by $T_{Jmax}$	1700	
$P_D$	Maximum Power Dissipation		1500	W

## THERMAL AND MODULE CHARACTERISTICS

 *$T_C=25^\circ C$  unless otherwise specified*

Symbol	Parameter/Test Conditions		Values	Unit
$R_{thJC}$	Thermal resistance, junction to case Per MOSFET		0.1	K/W
$T_{Jmax}$	Max. Junction Temperature		175	°C
$T_{STG}$	Storage Temperature Range		-40~125	
<b>Torque</b>	to heatsink	Recommended (M5)	2.5~5	Nm
	to terminal	Recommended (M5)	2.5~5	
<b>Weight</b>			240	g

## ELECTRICAL CHARACTERISTICS

 $T_C = 25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=600\mu\text{A}$	150			V
$R_{DS(\text{ON})}$	Drain Source ON Resistance	$V_{GS}=10\text{V}, I_D=600\text{A}$		1.8	2.1	$\text{m}\Omega$
$I_{DSS}$	Drain Source Leakage Current	$V_{DS}=150\text{V}, V_{GS}=0\text{V}$			2	mA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D=1.6\text{mA}$	3	4	5	V
$I_{GSS}$	Gate Leakage Current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}(\text{module})$	-2		2	mA
$Q_g$	Total Gate Charge	$V_{DD}=75\text{V}, I_D=300\text{A}, V_{GS}=10\text{V}$		850		nC
$Q_{gs}$	Gate Source Charge			210		nC
$Q_{gd}$	Gate Drain Charge			320		nC
$g_{fs}$	Forward Transconductance	$V_{DS}=10\text{V}, I_D=300\text{A}$		496		S
$C_{iss}$	Input Capacitance	$V_{DS}=25\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		60		nF
$C_{oss}$	Output Capacitance			4.7		nF
$C_{rss}$	Reverse Transfer Capacitance			0.95		nF
$t_{d(on)}$	Turn on Delay Time	$V_{DD}=75\text{V}, I_D=300\text{A}, R_G=5\Omega, V_{GS}=15\text{V}$ (Inductive Load)	$T_J=25^\circ\text{C}$		230	ns
$t_r$	Rise Time				350	ns
$t_{d(off)}$	Turn off Delay Time				600	ns
$t_f$	Fall Time				310	ns
$E_{on}$	Turn on Energy				TBD	mJ
$E_{off}$	Turn off Energy				TBD	mJ

## Source-Drain BODY-DIODE CHARACTERISTICS

 $T_C = 25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
$I_{SD}$	Continuous Source Drain Current				600	A
$I_{SDM}$	Pulse Source Drain Current	Limited by $T_{J\text{max}}$			1200	A
$V_{SD}$	Forward Voltage	$I_S=300\text{A}, V_{GS}=0\text{V}$		1.0	1.2	V
$t_{rr}$	Reverse Recovery time	$I_F=300\text{A}, V_{GS}=0\text{V}$		150		ns
$Q_{rr}$	Reverse Recovery Charge	$dI_F/dt=-650\text{A}/\mu\text{s}$		6500		nC

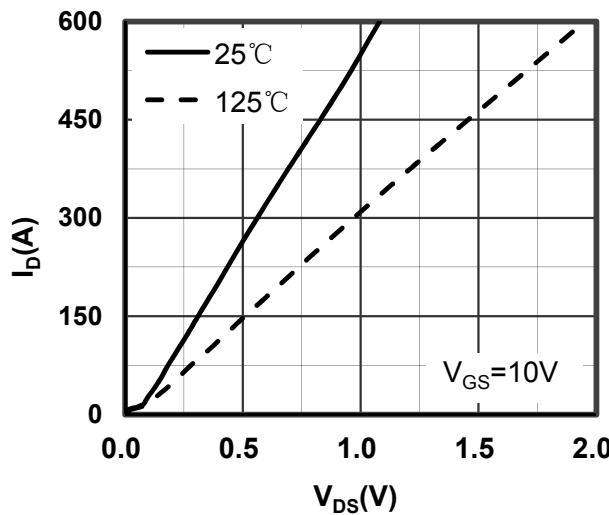


Figure 1. Typical Output Characteristics

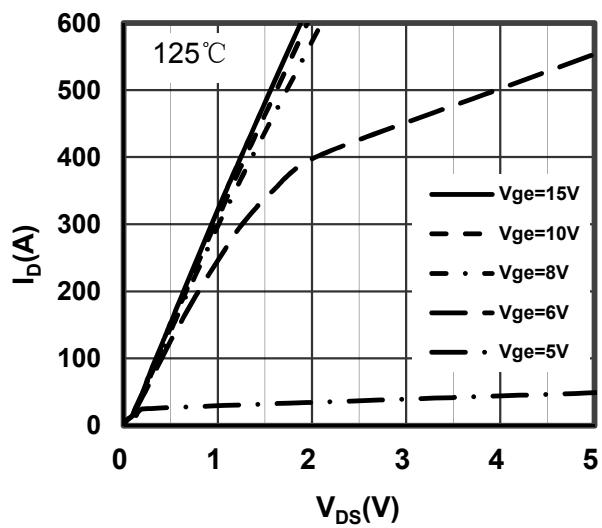


Figure 2. Typical Output Characteristics

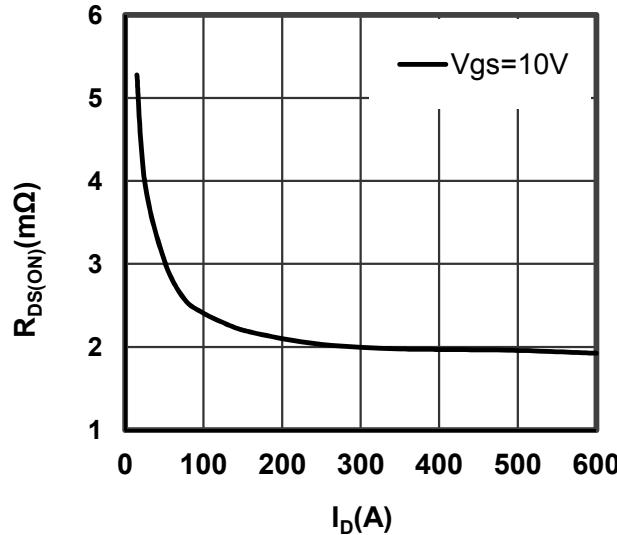
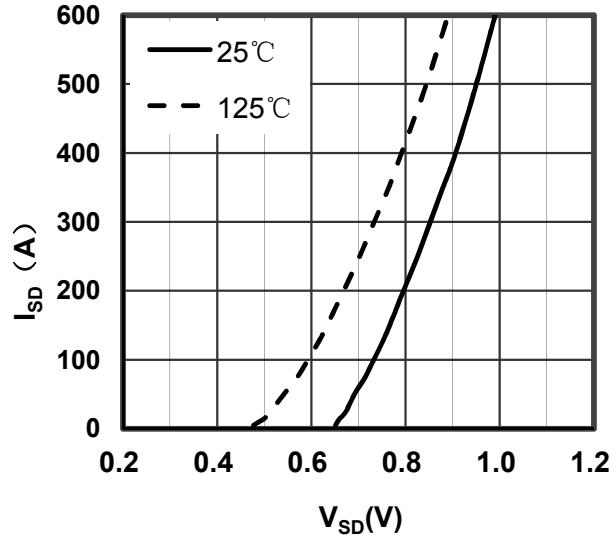
Figure 3. Drain-Source ON Resistance vs  $I_D$ 

Figure 4. Source-Drain Voltage

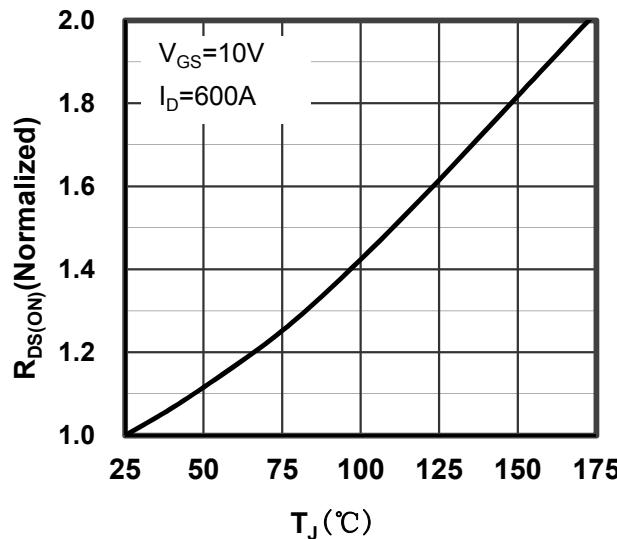


Figure 5. Drain-Source ON Resistance vs Junction Temperature

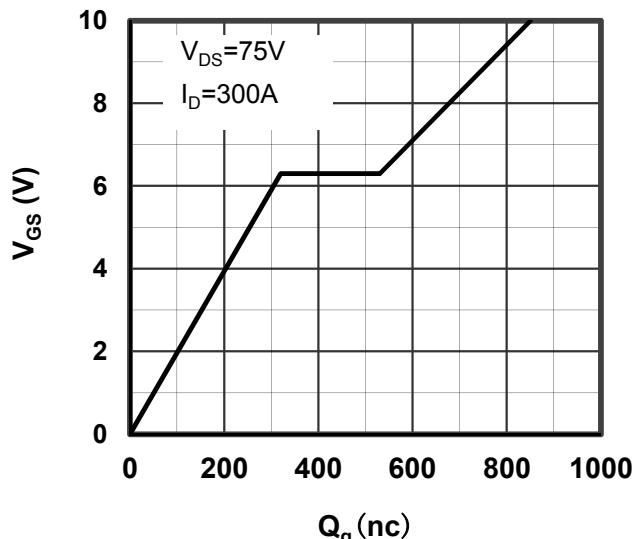
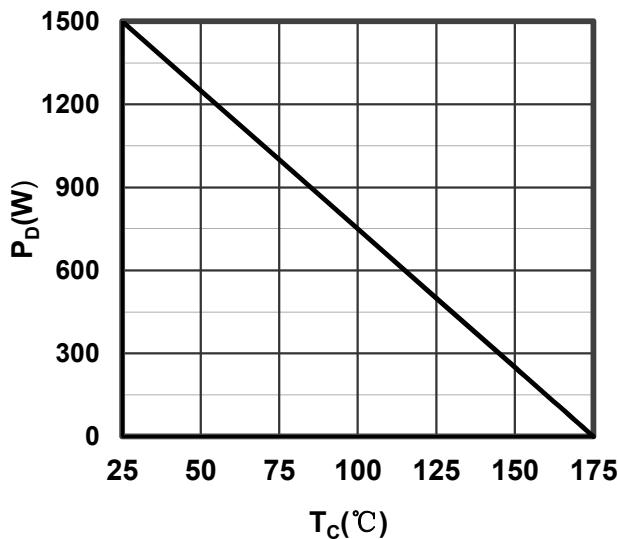
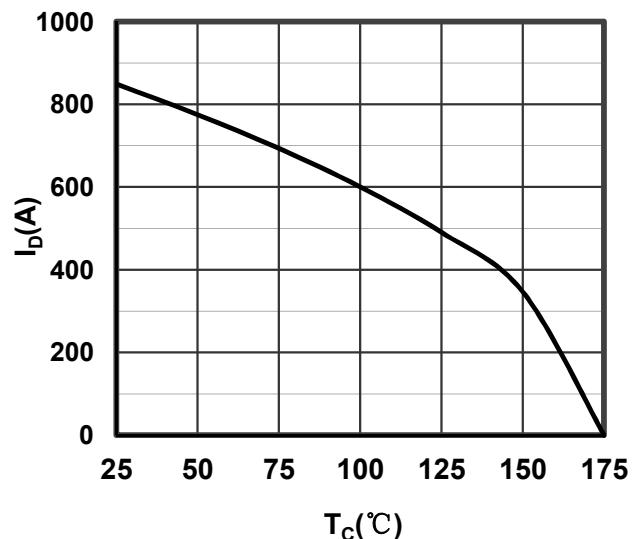


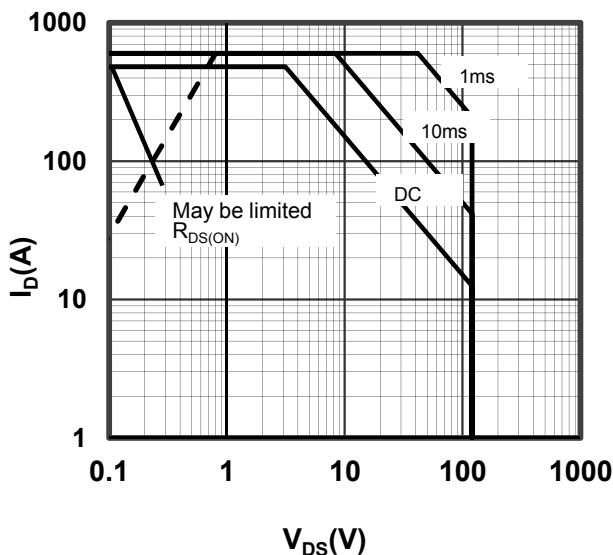
Figure 6. Gate Charge characteristics



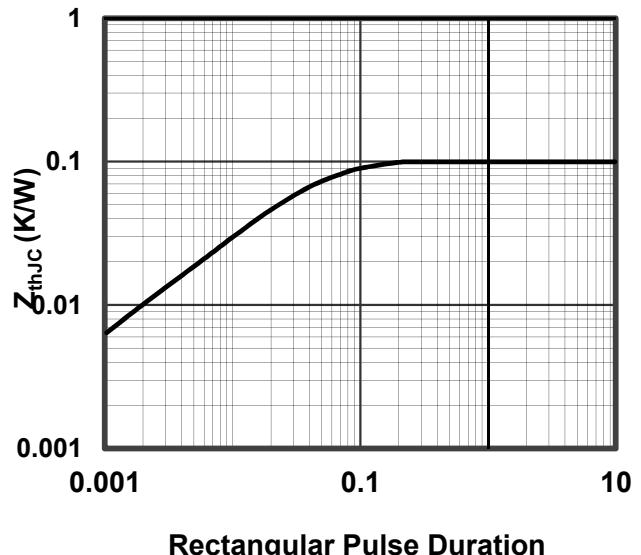
**Figure 7. Maximum Power Dissipation vs Case Temperature**



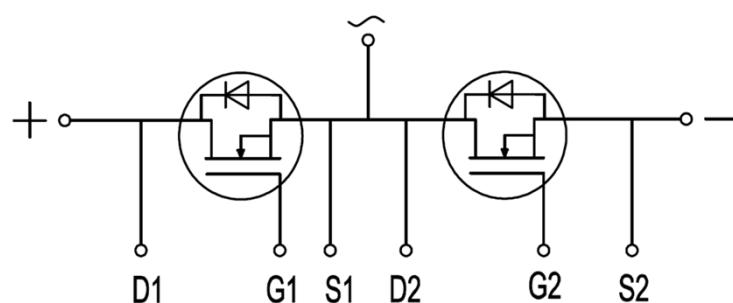
**Figure 8. Maximum Continuous Drain Current vs Case Temperature**



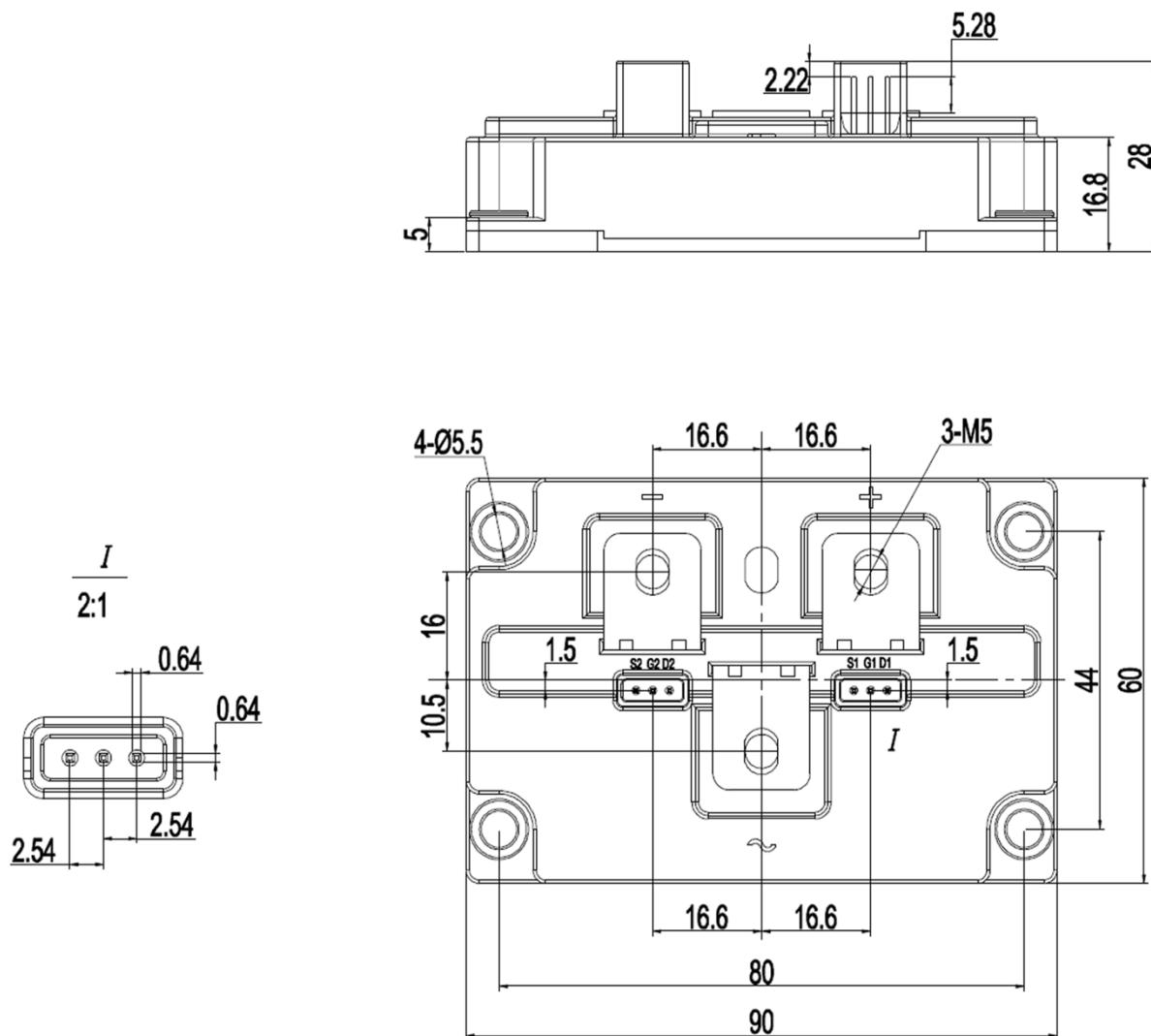
**Figure 9. Maximum Forward Safe Operation Area**



**Figure 10. Transient Thermal Impedance**



**Figure 11. Circuit Diagram**



**Dimensions in (mm)**  
**Figure 12. Package Outline**